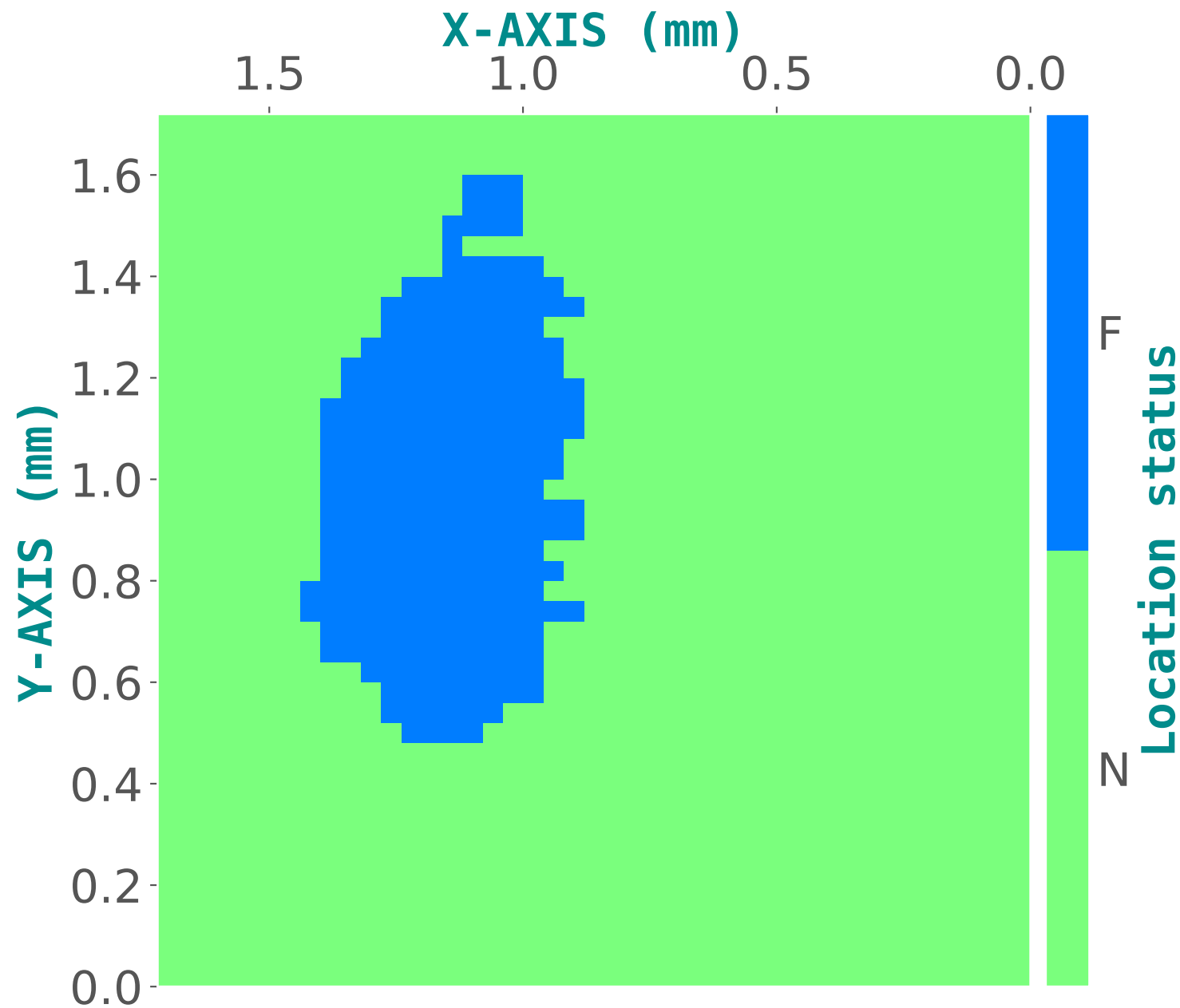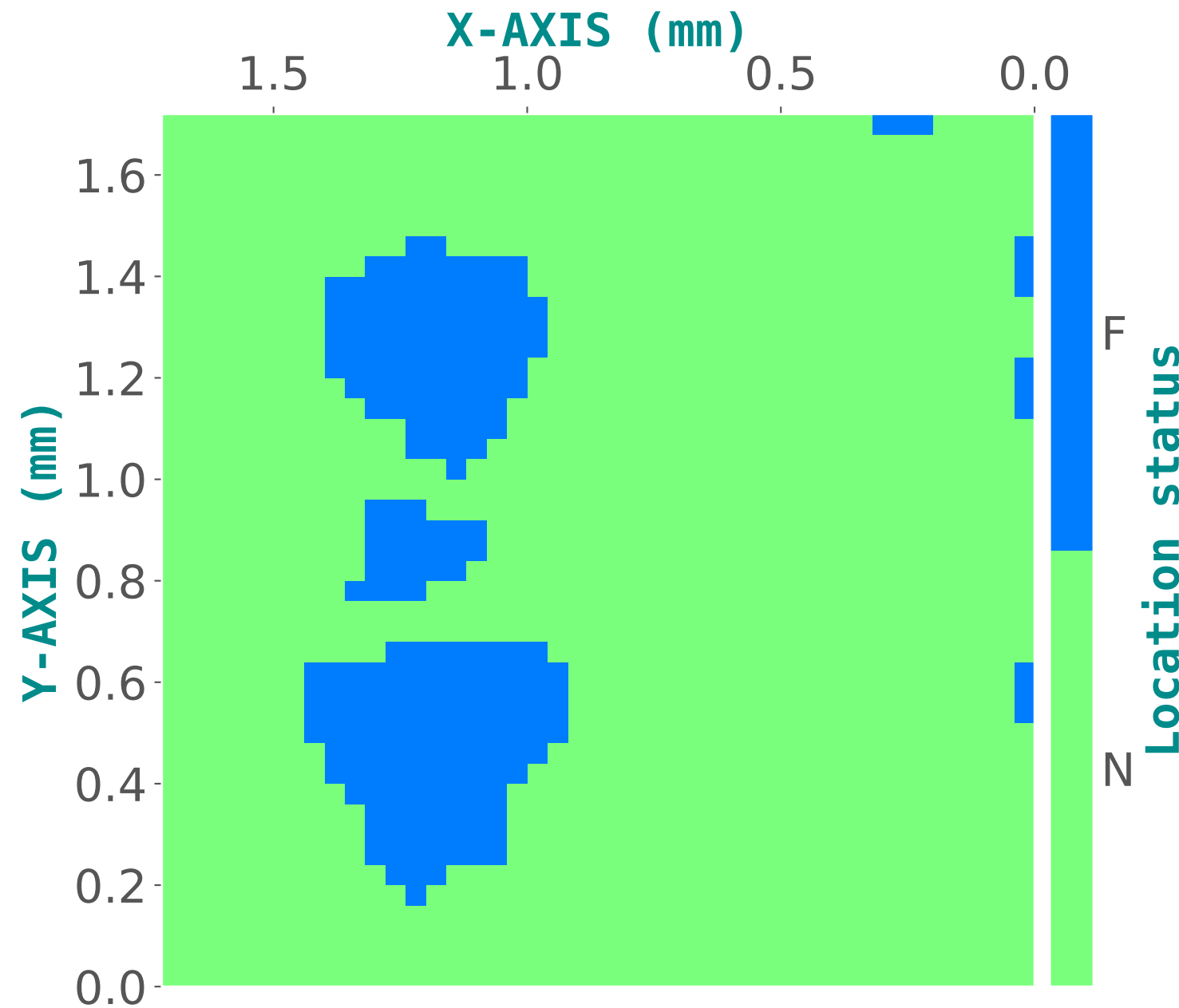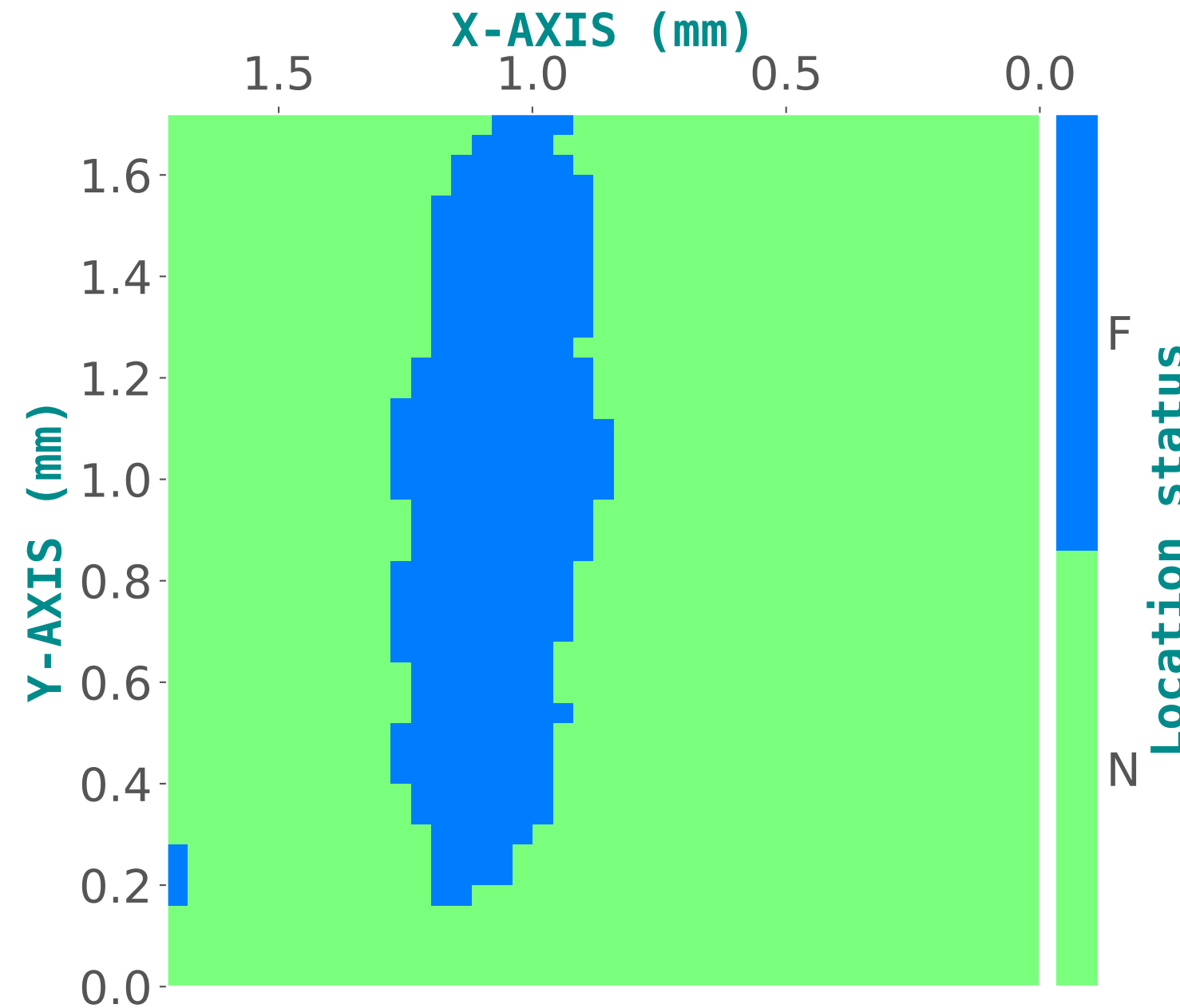200 μm, 140 μm and 50 μm susceptibility areas comparison (F = FAULT, N = NO FAULT)

A1 : 200 μm (ST200), -170 V, 0.416 mm^2, C_{A3-A1} = 64.6 %

A2 : 140 μm (ST140), -140 V, 0.3824 mm^2, C_{A2-A1} = 44.2 %

A3 : 50 μm (ST50), -100 V, 0.488 mm^2, C_{A3-A2} = 45.4 %